Notice of References Cited

Application/Control No. 10/768,032	Reexamination	Applicant(s)/Patent Under Reexamination FETZER ET AL.	
Examiner	Art Unit		
Adolfo Nino	2831	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,847,923	12-1998	Lee, Guiy Shing	361/684
	В	US-6,760,231	07-2004	Hung et al.	361/758
	С	US-6,749,072	06-2004	Matsuda et al.	361/758
	D	US-5,956,835	09-1999	Aksu, Allen	174/166S
	E	US-5,775,418	07-1998	Lonergan et al.	174/138G
	F	US-5,715,146	02-1998	Hoppal, John Pete	174/138G
	G	US-5,544,006	08-1996	Radloff et al.	174/138G
	н	US-5,138,116	08-1992	Kabayama, Sukehiro	174/138G
	ı	US-5,398,166	03-1995	Yonezawa et al.	361/758
	j	US-3,996,500	12-1976	Coules, Ronald A.	361/748
	К	US-3,621,173	11-1971	Theodore H. O'Cheskey	174/138G
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р			,		
	Ø					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	8	
	×	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.